



# IEEE 802.3 DTE Power via MDI

## Analysis and Implementation of Coupled Diode Detection

**Presented by PowerDsine:**

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## Coupled Diode Method

### Defining parameters for cost-effective implementation

- **PD Section**
  - Isolating Circuit
  
- **PSE (Switch, Mid-Span)**
  - Probing signal feeding methods with coupling transformer
  - Two transformers implementation
  - Single transformer implementation
  - Silicon implementation

**Acknowledgment to Rick Brooks & Larry Miller / Nortel**

**Their previous work is used as the baseline for this presentation**

## PD Section - Isolating Diode Bridge Rectifier

### ■ Advantages

- Simple
- Polarity insensitive.
- Low Cost

### ■ Issues to address

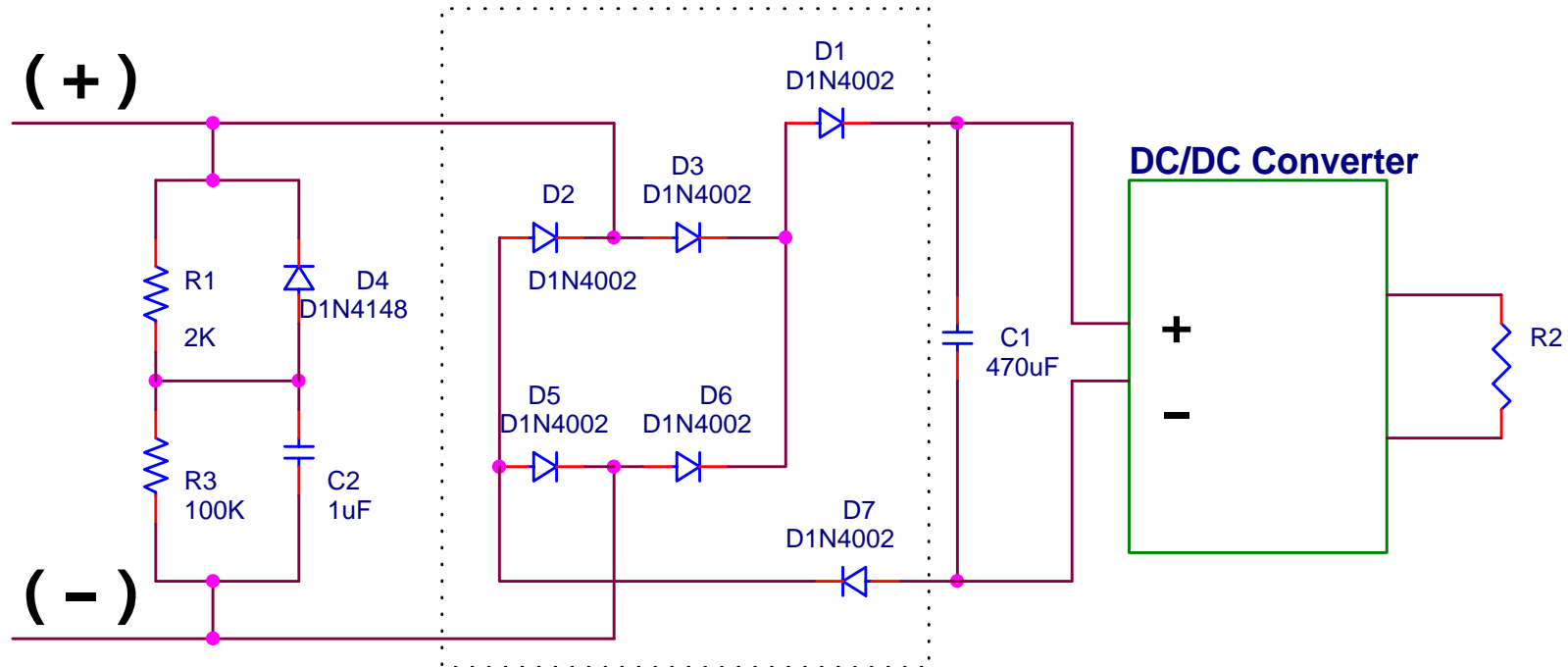
- Power & voltage drop ( $1W_{max}$ ,  $3V_{max}$ ), reduces PD available power
- Transmitted pulse amplitude is limited to  $4V_d$ , practical value about  $2V_{max}$ .
- Actual detected pulse amplitude is approximately  $1V$

## PD section- Enhanced Isolating Circuit

- Reliable implementation must include an Under Voltage protection circuit as part of the PD power supply input\*
- The UV circuitry may be utilized as the isolation block between the Coupled Diode signature element and the PD power supply

\* Refer to the PowerDsine IEEE 802.3af May 2000 presentation

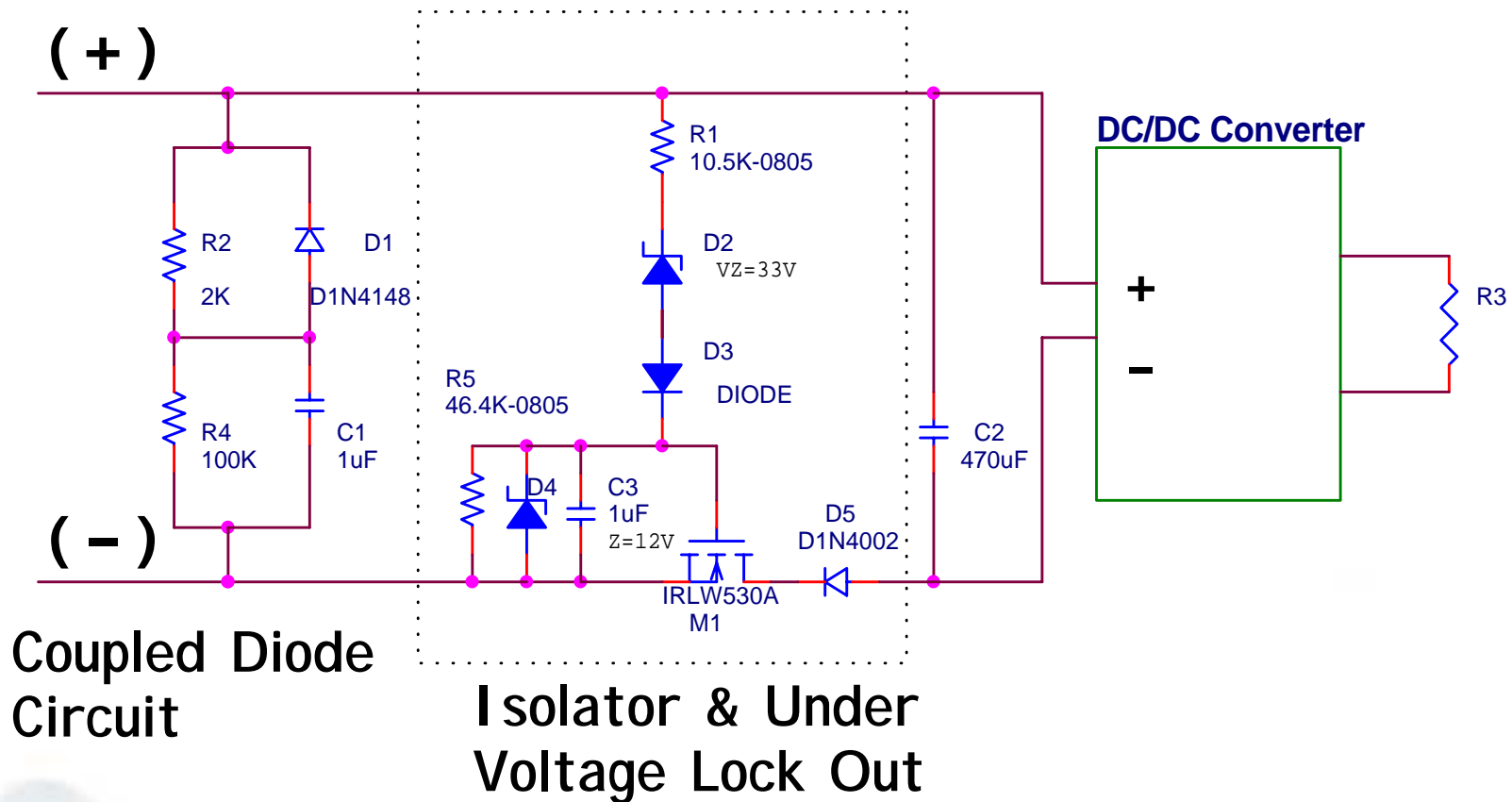
## PD Section - Isolation Circuitry



**Coupled Diode**

**Isolating Circuit**

## PD Section - Enhanced Isolation Circuitry



\* Hysteresis circuitry may be added for setting different On/Off thresholds

## PD section - Enhanced Isolating Circuitry

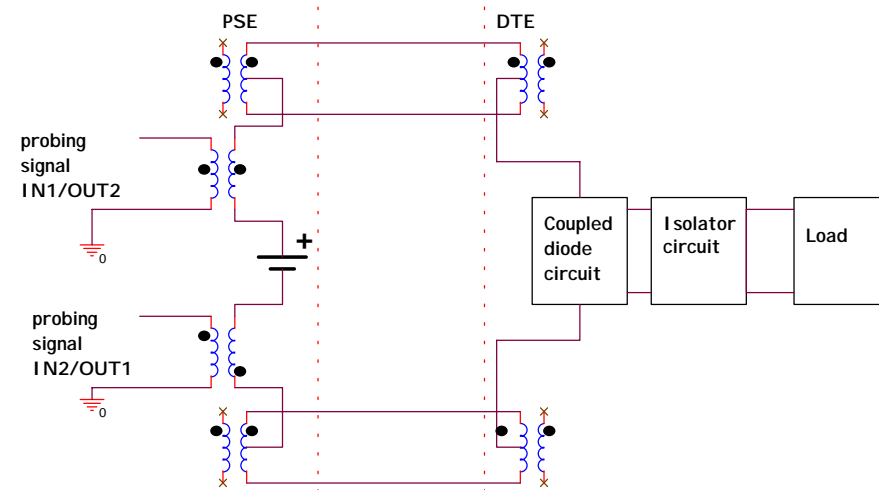
- Utilizing the existing UVLO
- Increases PD available power by reducing diodes power/voltage drop
- Probing pulses amplitude value range can be widen to improve signal to noise ratio and lower detected pulse sensitivity to circuit elements tolerance
- Lab testing confirms that the detected pulse shape is highly similar to one measured using the Diode Bridge

# PSE - Pulse Amplitude Limitations

## Setup A

### Nortel proposed setup

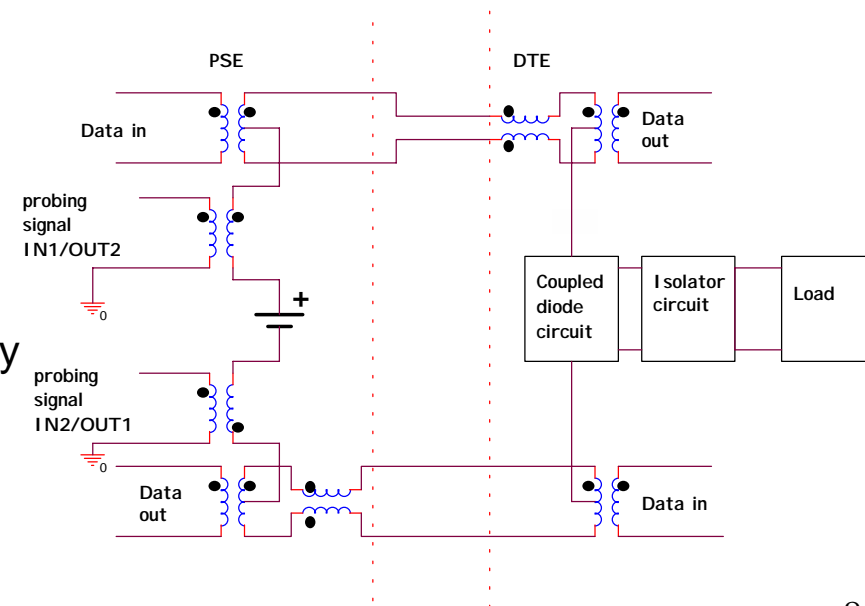
- Mid-Span solution architecture



## Setup B

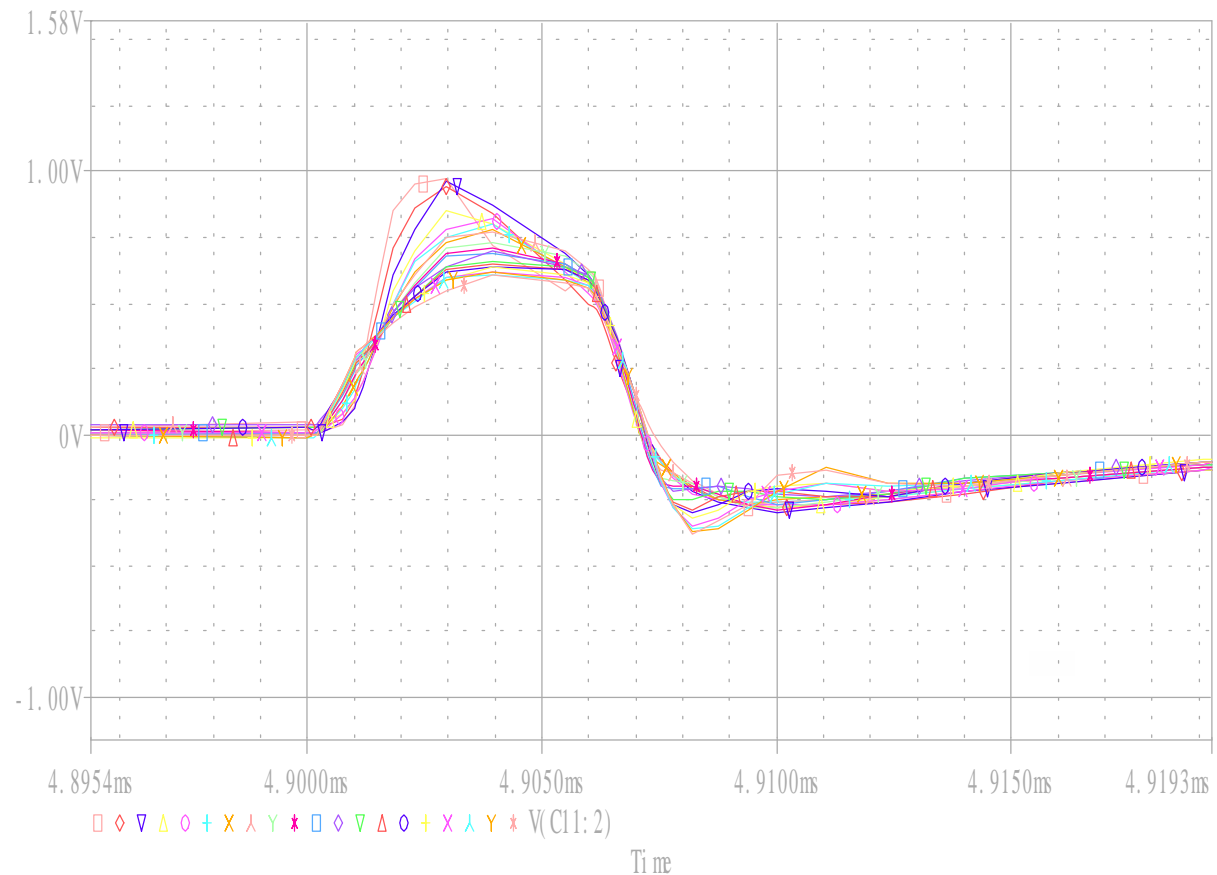
### Power is Phantom fed through standard data transformer module including integrated data path common mode filter

- Switch solution architecture
- Common mode filter inductance may vary in range of 2-120uH (depends on application, vendors etc.)



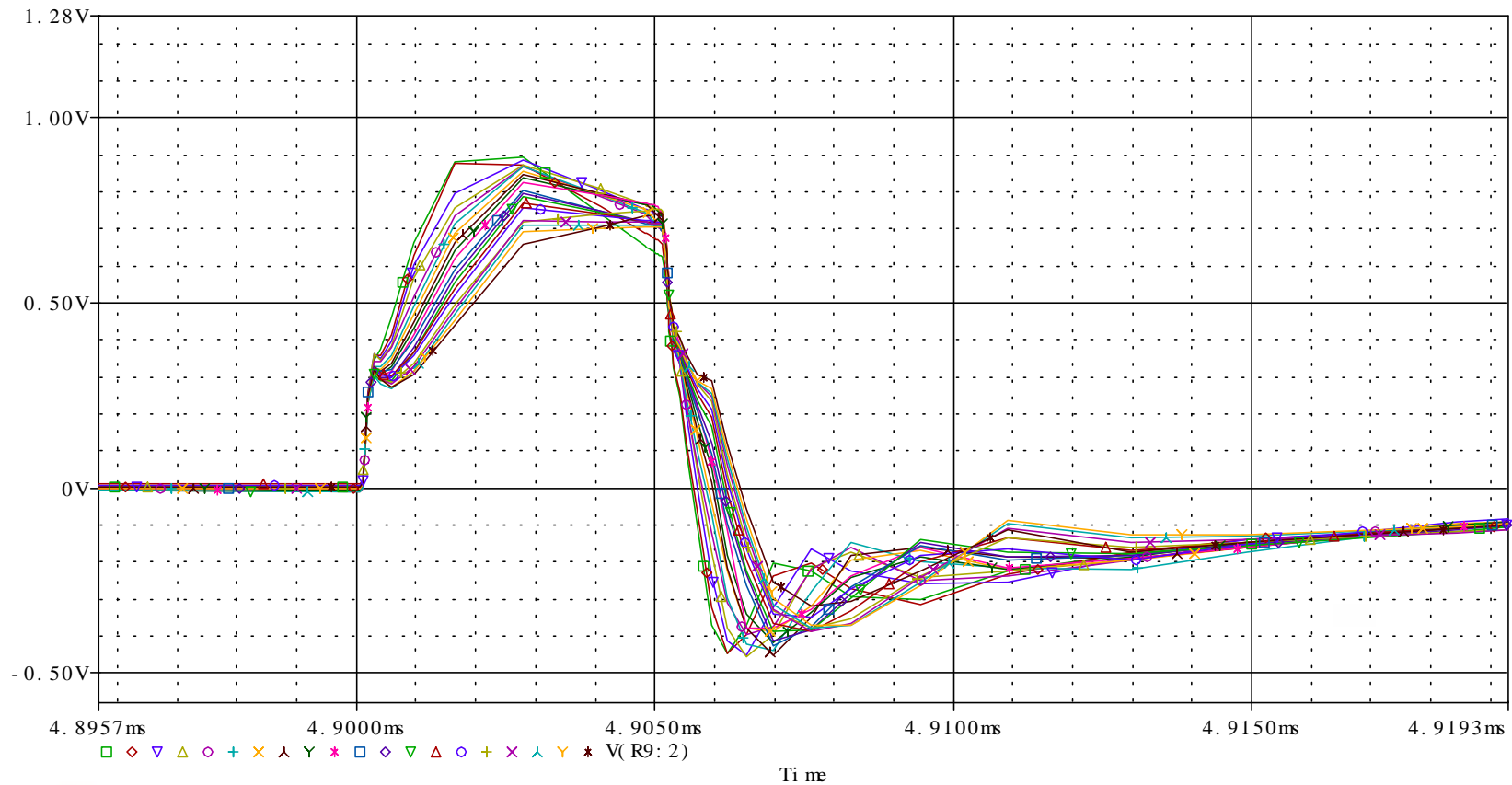


## Detected Pulse Shape Vs. Link Length



**Setup A: Link length=0-100m, 5m steps**

## Detected Pulse Shape vs. Link Length



**Setup B: Link length = 100m, 0-100uH Common Mode inductance, 5uH steps**

**Refer to Annex C for details**

## Recommendations

### Setup A:

- Detected signal shape changes within acceptable detected and processed range

### Setup B:

- Pulse leading edge changes significantly with series inductance
- Pulse sampling time should be positioned close to tailing edge for robust detection

### Note

- While power over MDI is supplied the Common Mode filter inductance that is located inside the link will be significantly reduced due to core saturation. This may affect common mode noise rejection. Consider locating Common Mode filter external to the link side

## PSE Detection Circuitry Implementations

- Proposed coupled diode concept requires two coupling transformers
  
- Questions
  - Can we reduce it to single transformer?
  - Can we find solutions that can fit on Silicon?
  
- Goal:
- Specifying pulse shape parameters which do not limit the implementation methods



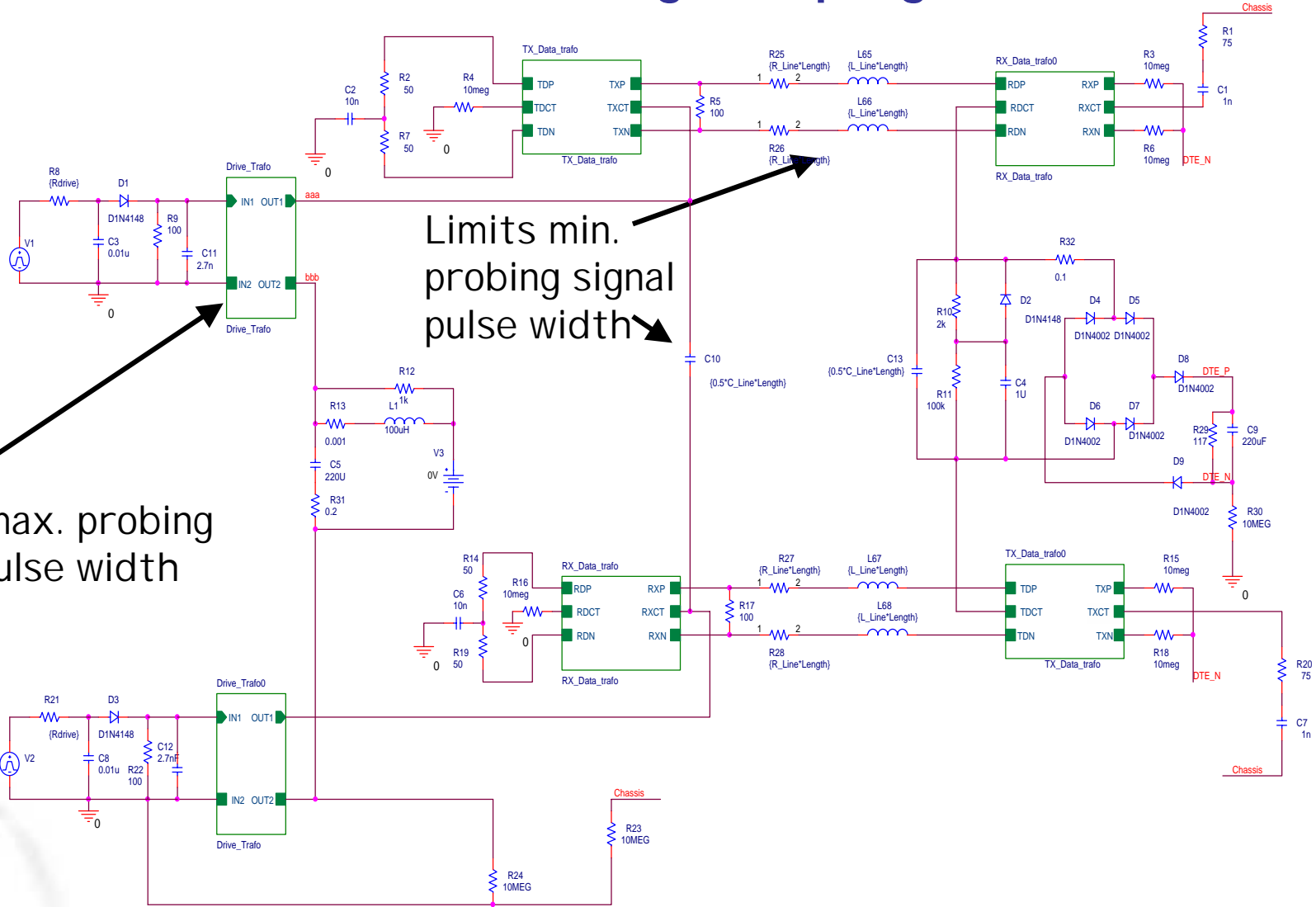
# Two Transformers Circuitry

## Can We Reduce it to a single Coupling Transformer?

IEEE 802.3af, Sep. 2000.

**PARAMETERS:**

$k\_data = 0.998$   
 $L\_data = 350u$   
 $L\_data1 = 350u$   
 $L\_cm = 100u$   
  
 $Rdrive = 12$   
 $Vdrive = 3.3$   
  
 $K\_Drive = 0.9997$   
 $L\_Drive = 1.2mH$   
 $N\_Drive = 1$   
  
 $Length = 100\ m$   
 $R\_Line = 0.125\ /m\ (Scaled)$   
 $L\_Line = 0.3uH\ /m\ (Scaled)$   
 $C\_Line = 15pF\ /m\ (Scaled)$

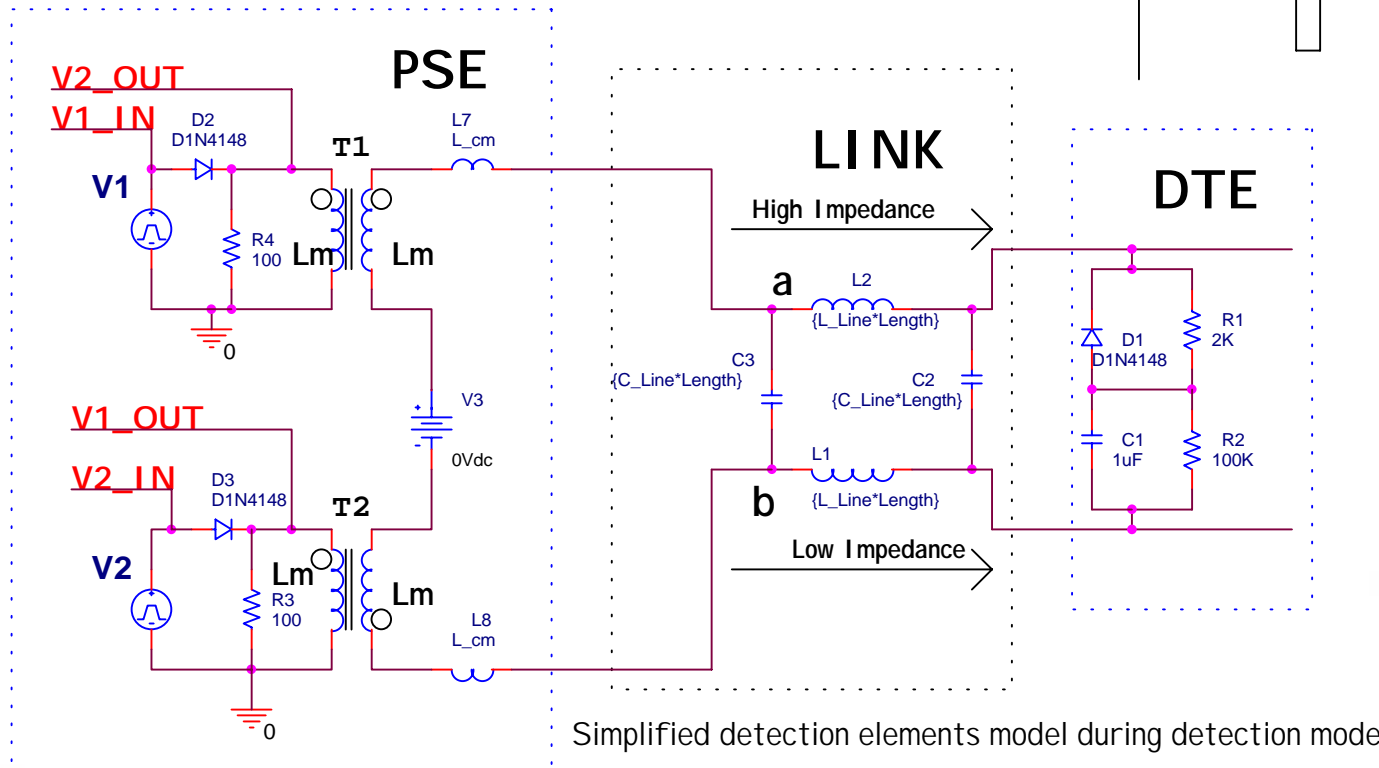


Limits max. probing signal pulse width

Limits min. probing signal pulse width

# Simplified Two Transformer Circuitry Representation

## Series Voltage Feed



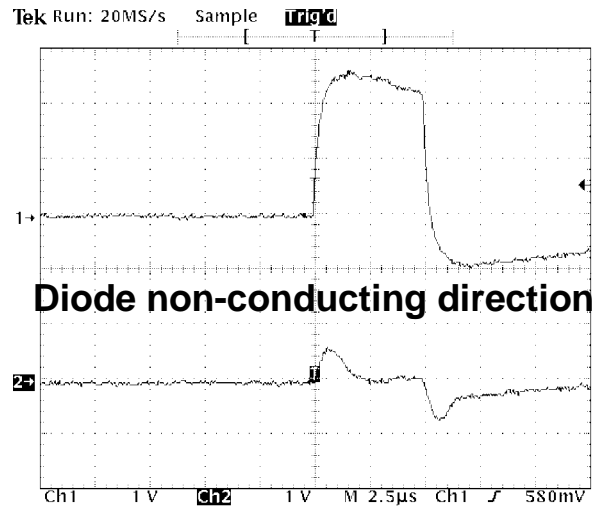
Sensed voltage wave shape is within acceptable distortion level while  $L_m \gg$  Total Series impedance (Refer to Annex A for details)



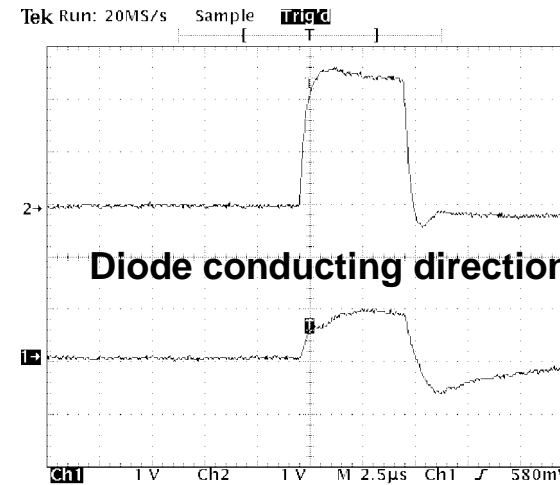
# Two Transformer Circuit - Test Results

## Setup A & B measurements, 100m Cat 5 UTP cable

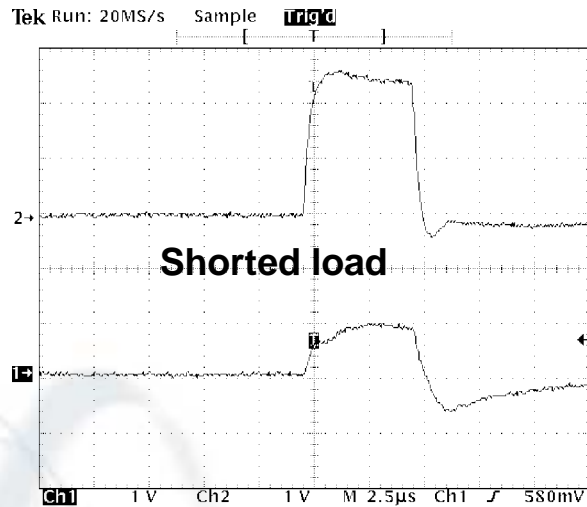
IEEE 802.3af, Sep. 2000.



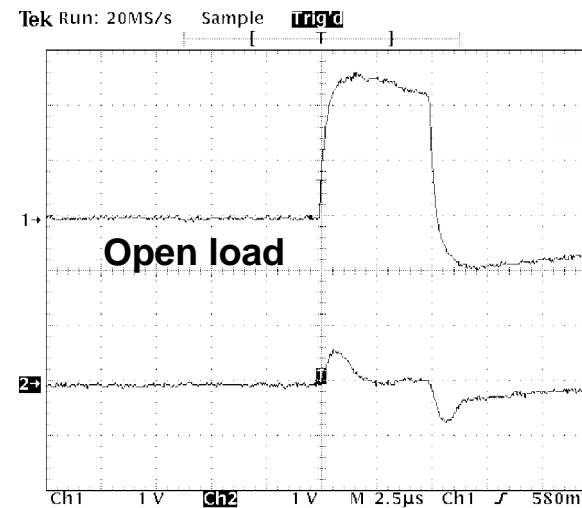
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11:34:15



28 Aug 2000  
11:27:25



28 Aug 2000  
11:27:25



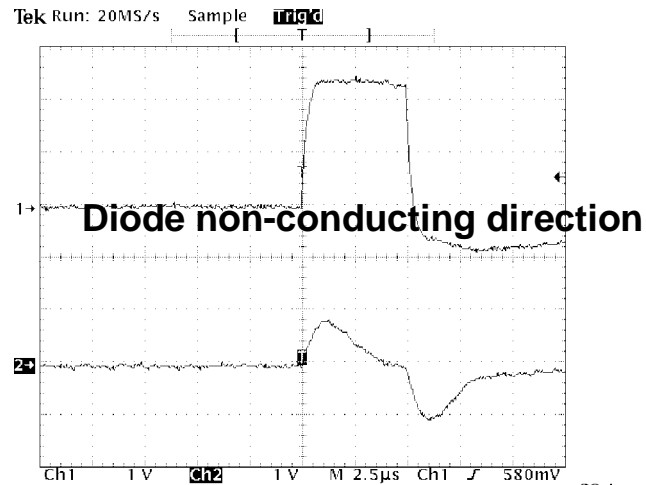
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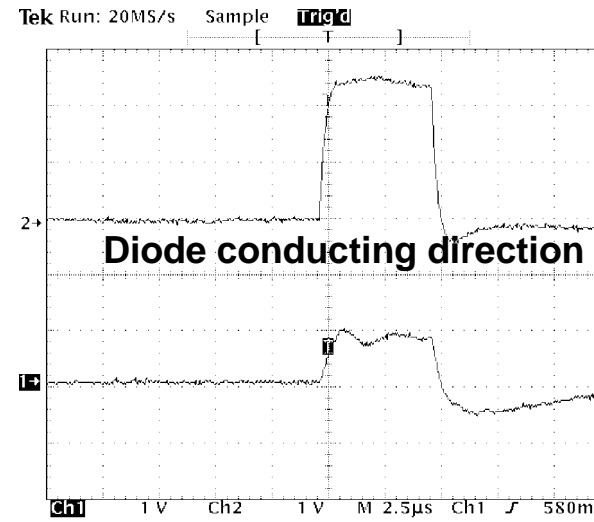
# Two Transformer Circuit - Test Results

## Setup A & B measurements, 100m Cat 5 FTP cable

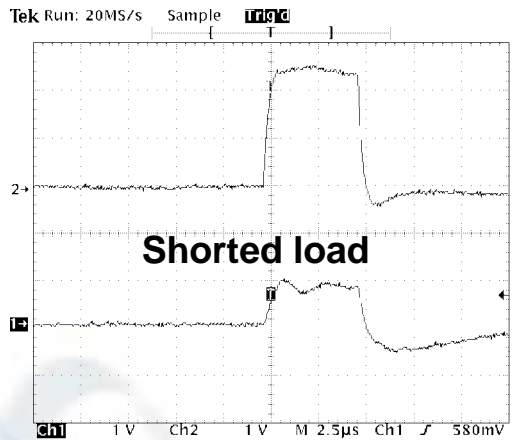
IEEE 802.3af, Sep. 2000.



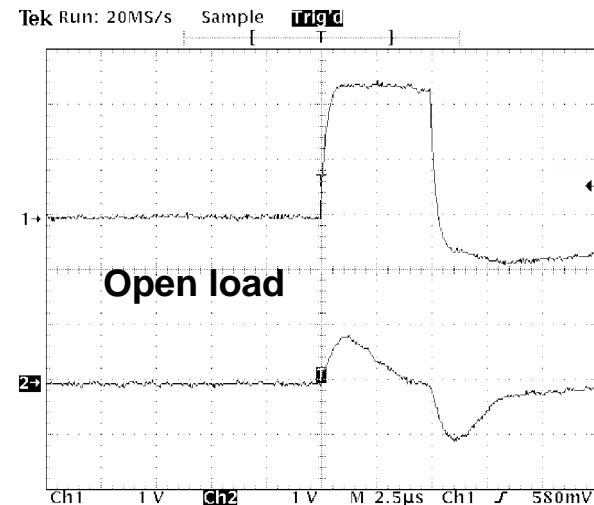
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28 Aug 2000  
11:25:44



28 Aug 2000  
11:36:33

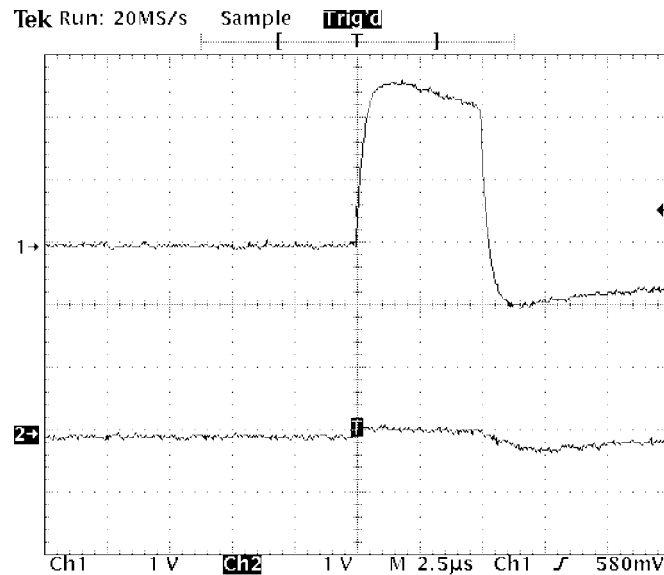




# Two Transformer Circuit - Test Results

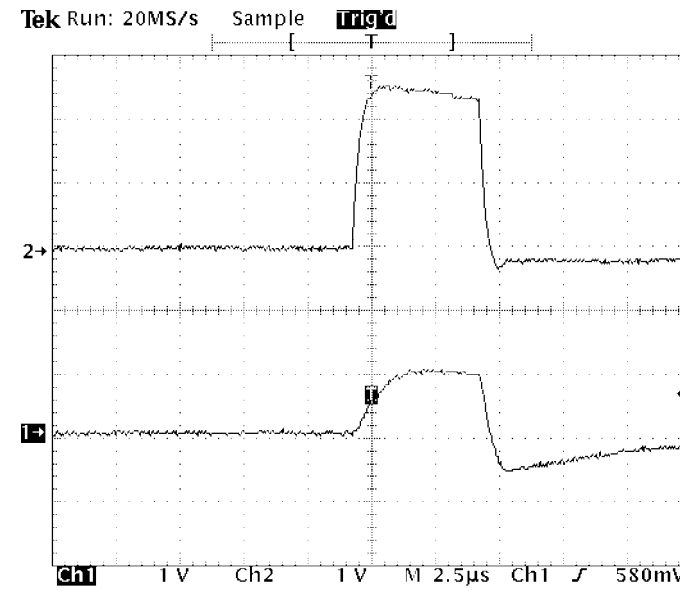
IEEE 802.3af, Sep. 2000.

## Setup A & B measurements, 0.2m Cat 5 FTP/UTP cable



28 Aug 2000  
11:39:51

Diode non-conducting direction



28 Aug 2000  
11:23:26

Diode conducting direction

## Two Transformer Circuit - Test Results

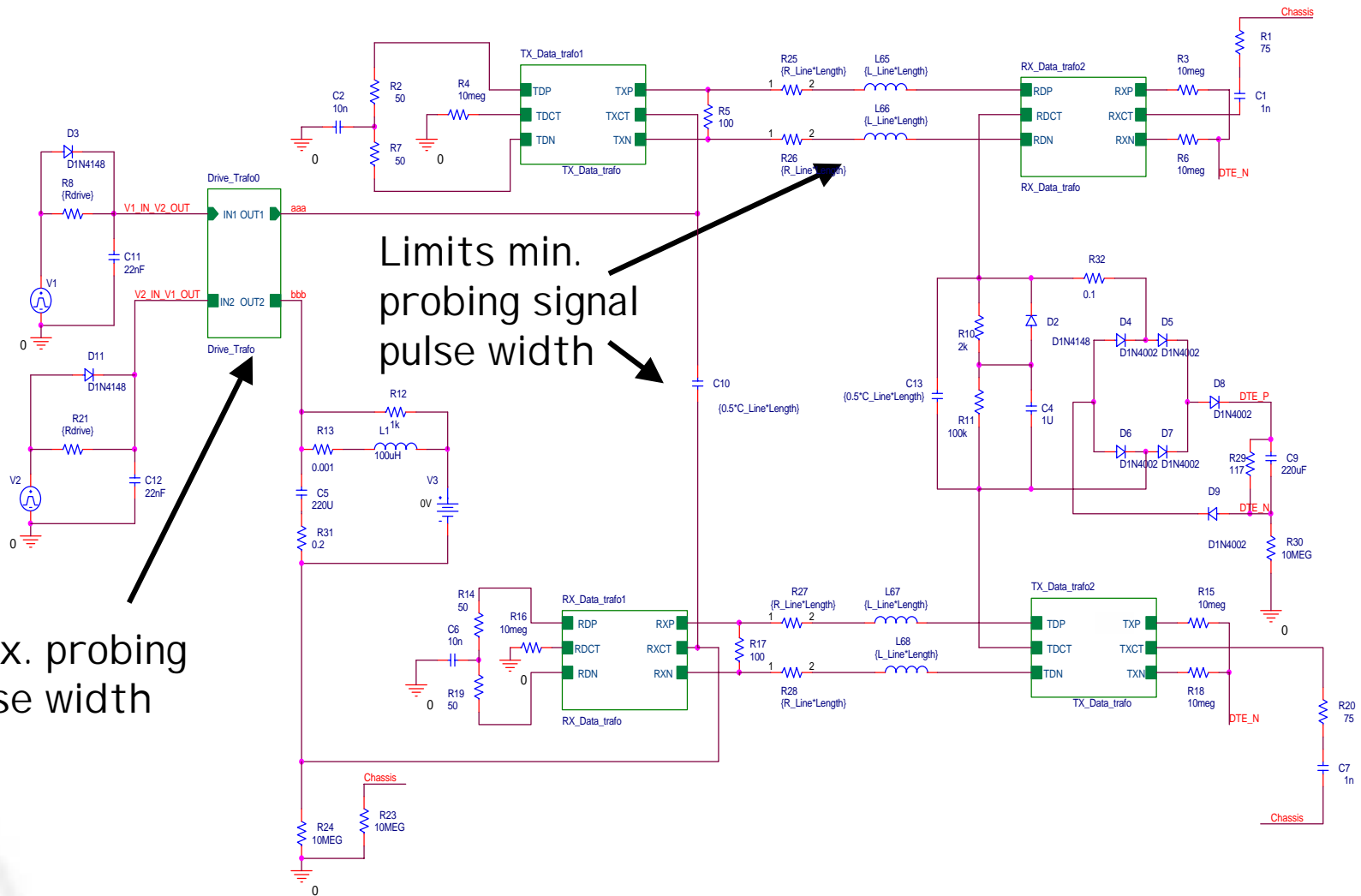
- Measured results confirm those presented by Rick Brooks & Larry Miller / Nortel at the July 2000 meeting
- The detected signal is affected by the Cat 5 cable equivalent input capacitance between pairs (by-passing Coupled Diode Signature element)
  - Simple High Pass filter at receive side can improve performance



# Reduction to Single Transformer Circuit

**PARAMETERS:**

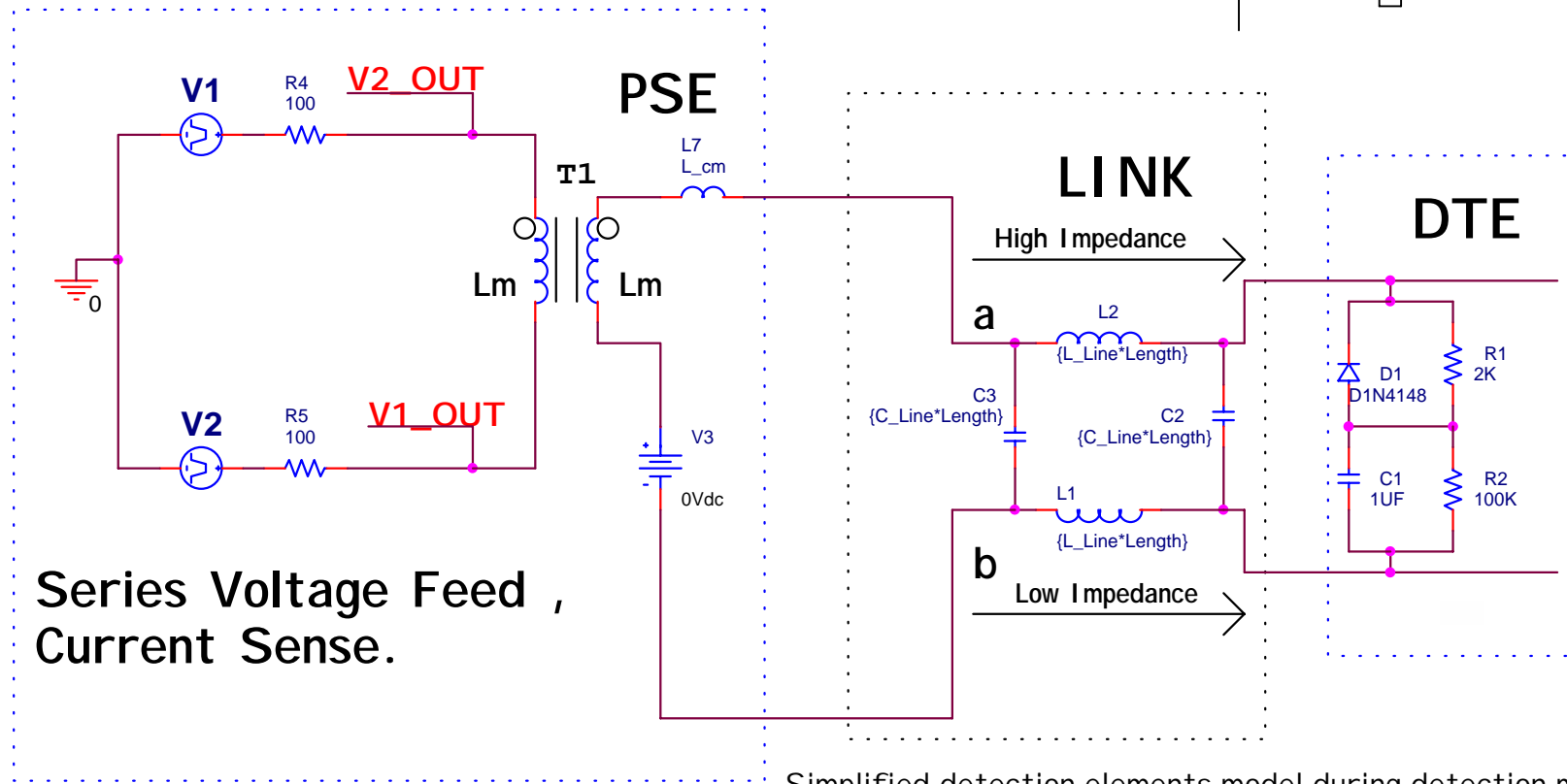
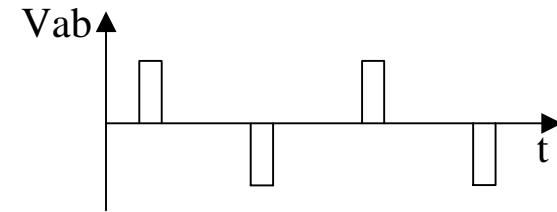
k\_data = 0.998  
 L\_data = 350u  
 L\_data1 = 350u  
 L\_cm = 100u  
  
 Rdrive = 100  
 Vdrive = 2  
  
 K\_Drive = 0.9997  
 L\_Drive = 5mH  
 N\_Drive = 1  
  
 Length = 100 m  
 R\_Line = 0.125 /m  
 L\_Line = 0.3uH /m (Scaled)  
 C\_Line = 15p /m (Scaled)



Limits max. probing signal pulse width

Limits min. probing signal pulse width

## Simplified Single Transformer Circuit Model



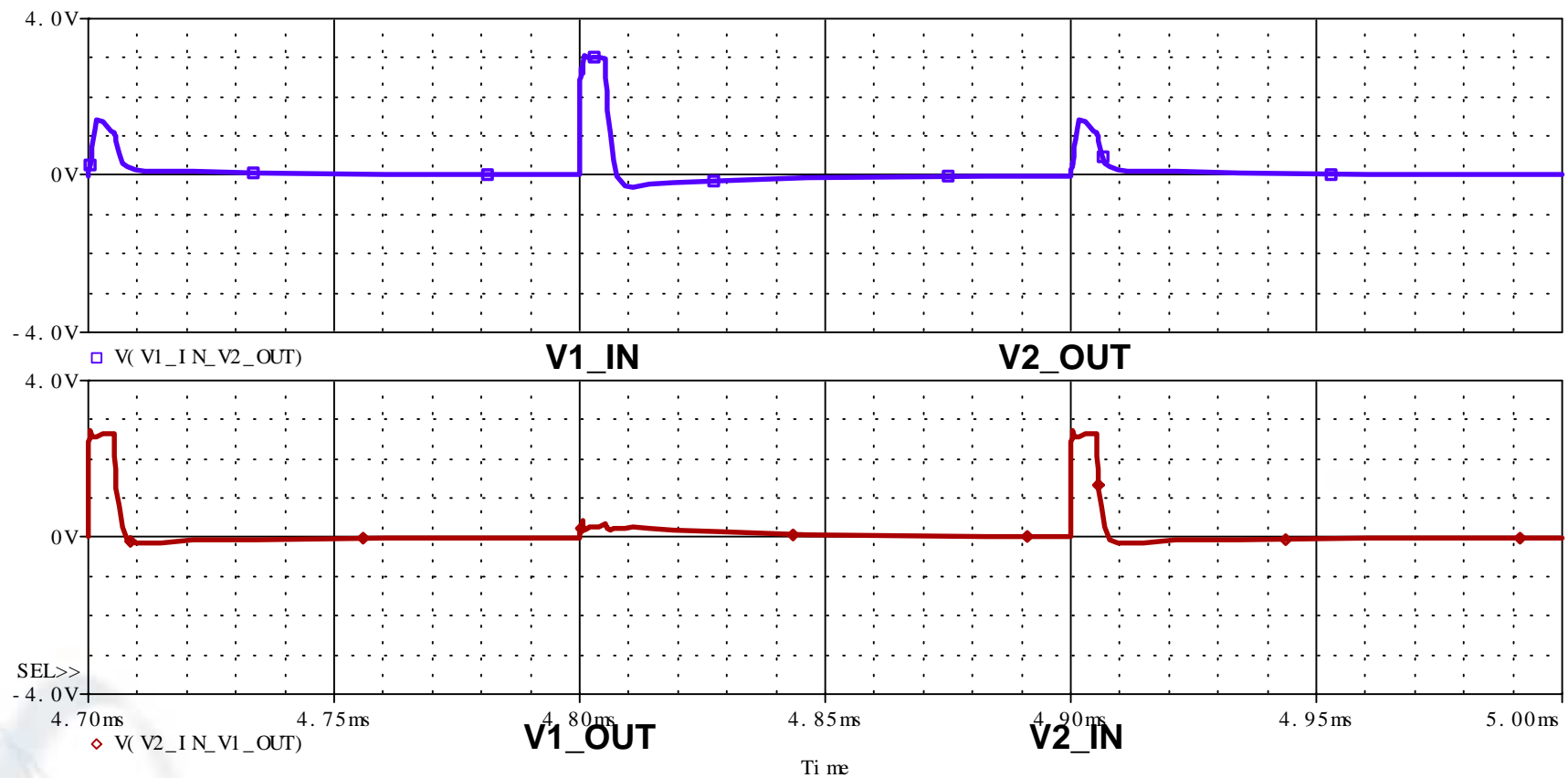
**Sensed voltage wave shape is within acceptable distortion level while  $I_m \ll I_{short}$  (Refer to Annex B for details)**

## Single Transformer Circuit - Concept Principles

- Coupling transformer primary inputs are driven with two low impedance pulse source introducing 180 degree phase shift.
- Sensing Primary current for short / open condition (Coupled diode is conducting or reversed biased)
- Primary winding is always closed circuit to ground.
  - Clean and noise-free pulse shape at secondary.
- Pulse parameters requirements are compatible with 2 transformer solution

## Single Transformer Circuit - Simulation

- Setup: 100m Cat 5 UTP cable
- Cable parameters measured between pairs 4/5 to 7/8 and 1/2 to 3/6

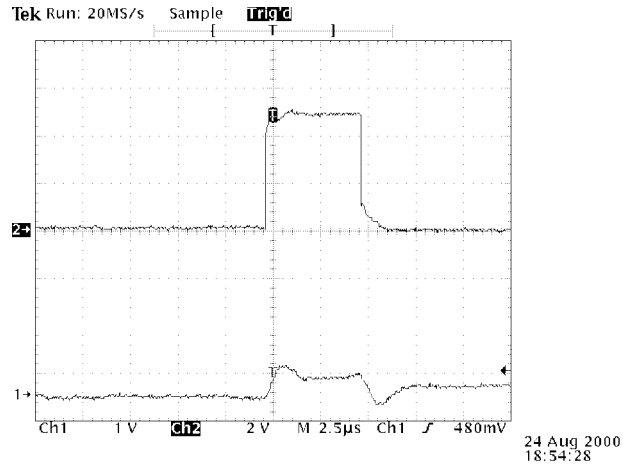




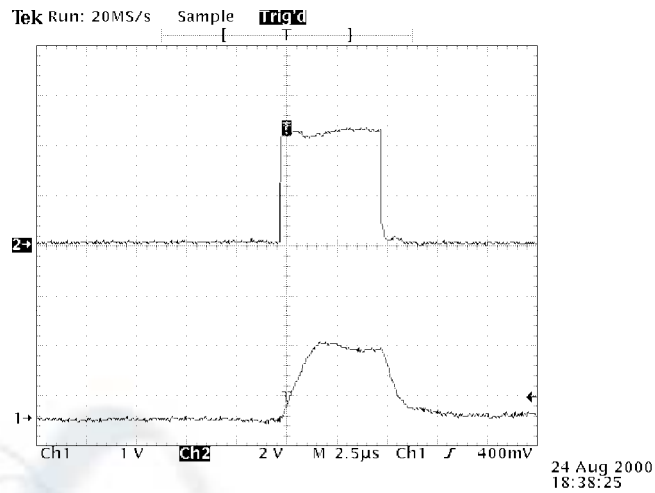
# Single Transformer Circuit - Measurements

IEEE 802.3af, Sep. 2000.

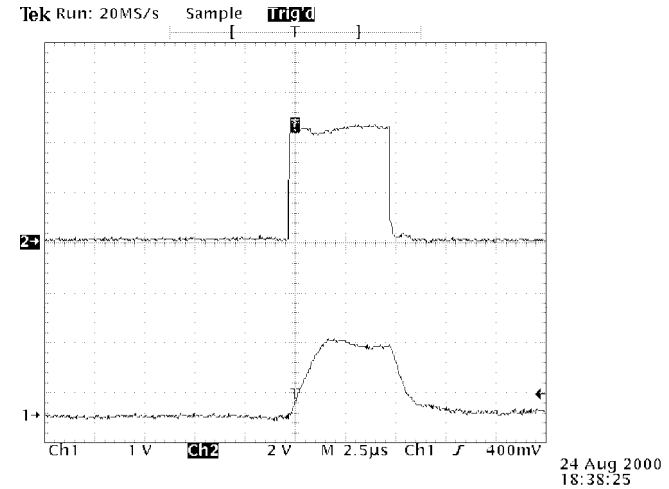
## Setup A & B, 100m Cat 5, UTP cable



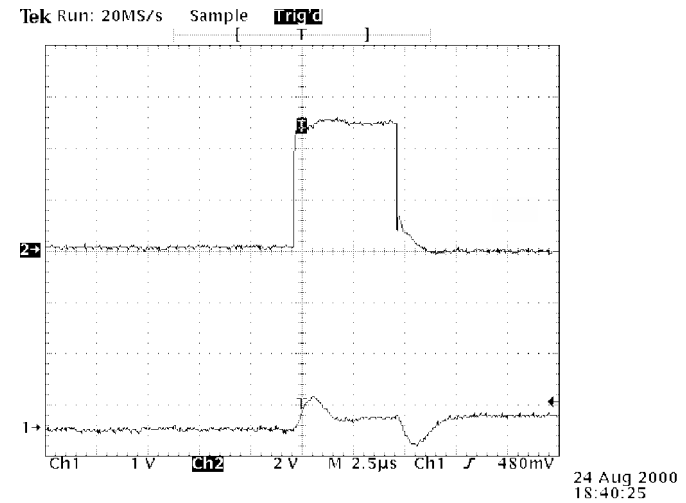
**Diode non-conducting direction**



**Shorted load**



**Diode conducting direction**



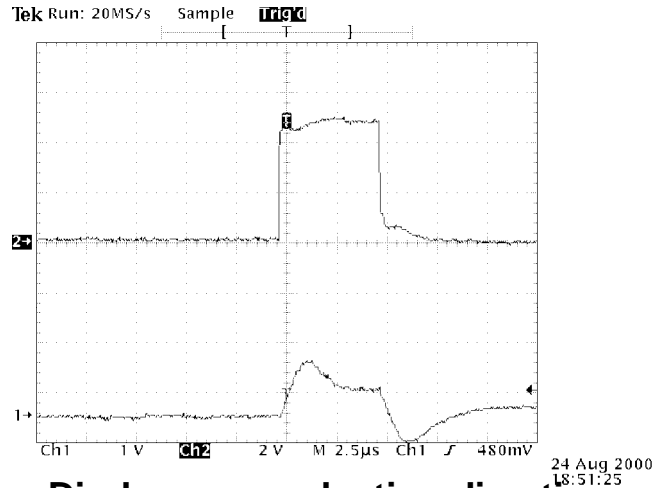
**Open load**



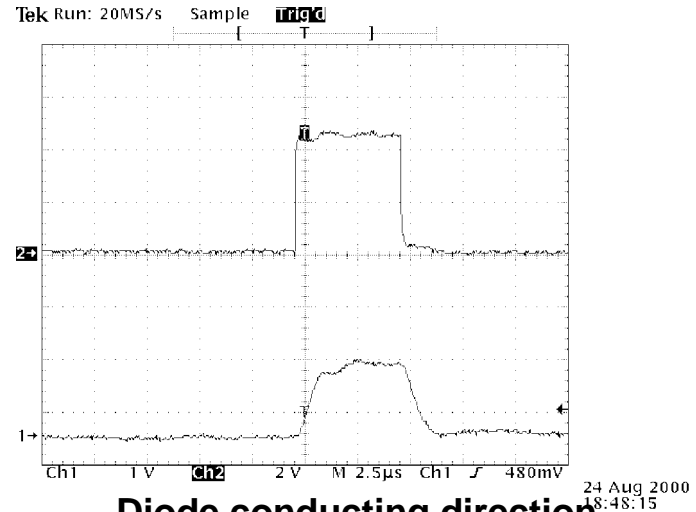
# Single Transformer Circuit - Measurements

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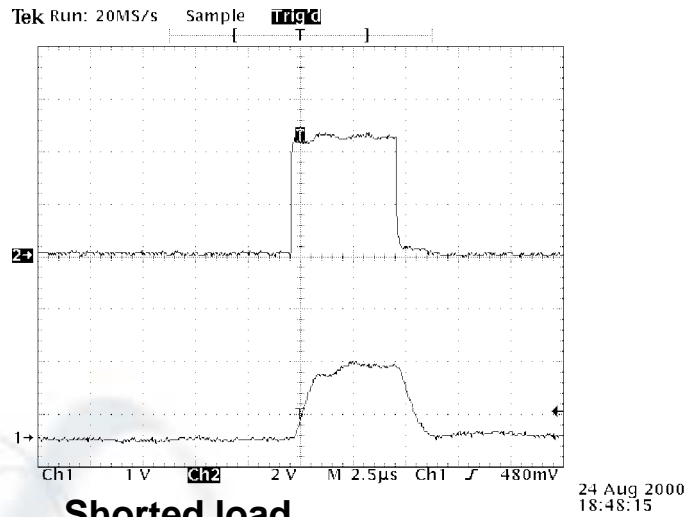
Setup: Mid-Span, 100m Cat 5 FTP cable



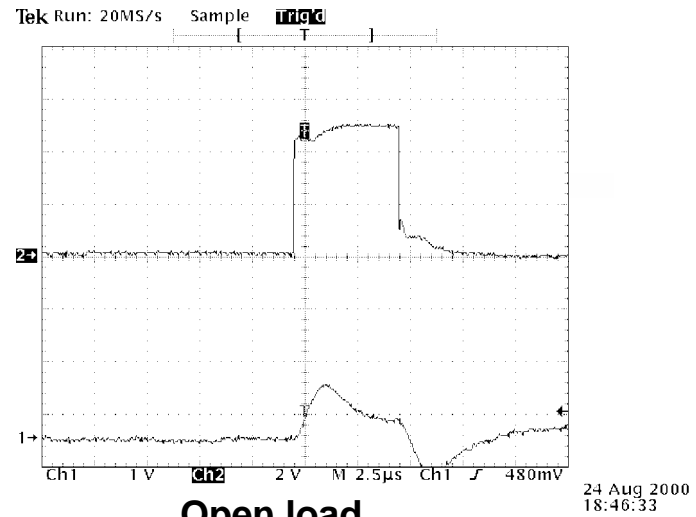
**Diode non-conducting direction**



**Diode conducting direction**



**Shorted load**



**Open load**

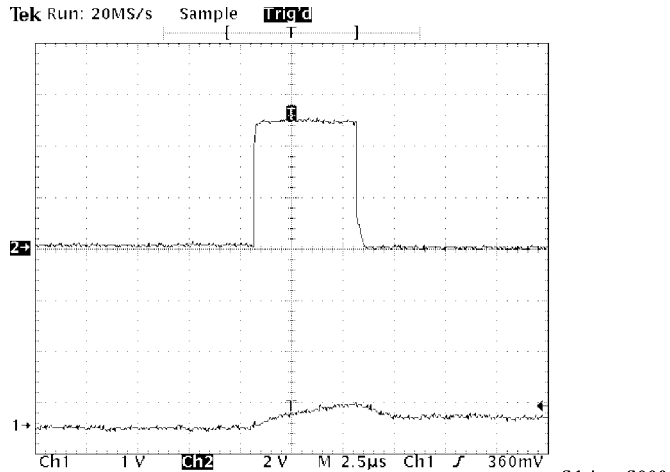




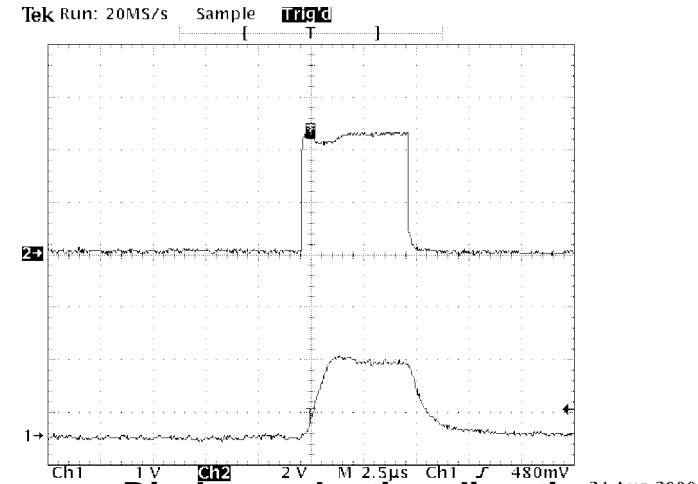
# Single Transformer Circuit - Measurements

IEEE 802.3af, Sep. 2000.

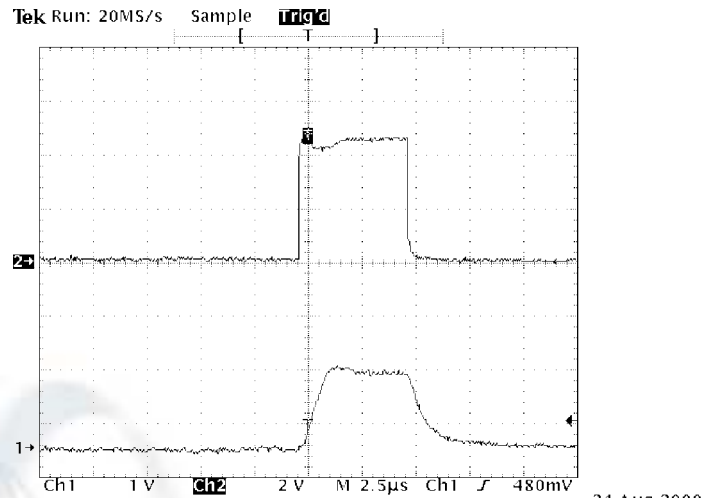
Setup: Mid-Span, 20cm Cat 5 UTP cable



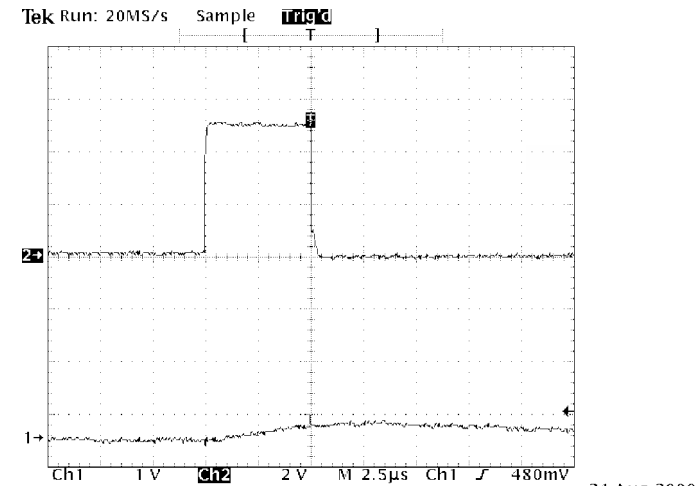
Diode non-conducting direction



Diode conducting direction



Shorted load



Open load

## Single Transformer Circuit - Conclusions

- Utilizing a single coupling transformer is feasible
- Similar results were observed for both A and B setup

## Comparison Between Single / Double Transformers

Parameter	Probing signal sensing method	
	Single Transformer	Double Transformer
Min. Primary inductance	4mH	1.350mH
Operating mode	Voltage pulse transformer	Voltage pulse transformer
Footprint	about 0.6X	1" x 0.5" = X
Cost	TBD	TBD

\*Further investigation and testing should be performed to evaluate impact on cost and footprint

## Coupled Diode Implementation Limitations

- Series voltage pulses feeding requires coupling transformers
- Implementing this scheme without using coupling transformers must utilize a different type of probing pulse feeding method
- Parallel voltage pulse feeding is required to allow future Silicon implementation



# Transformer-less Implementation

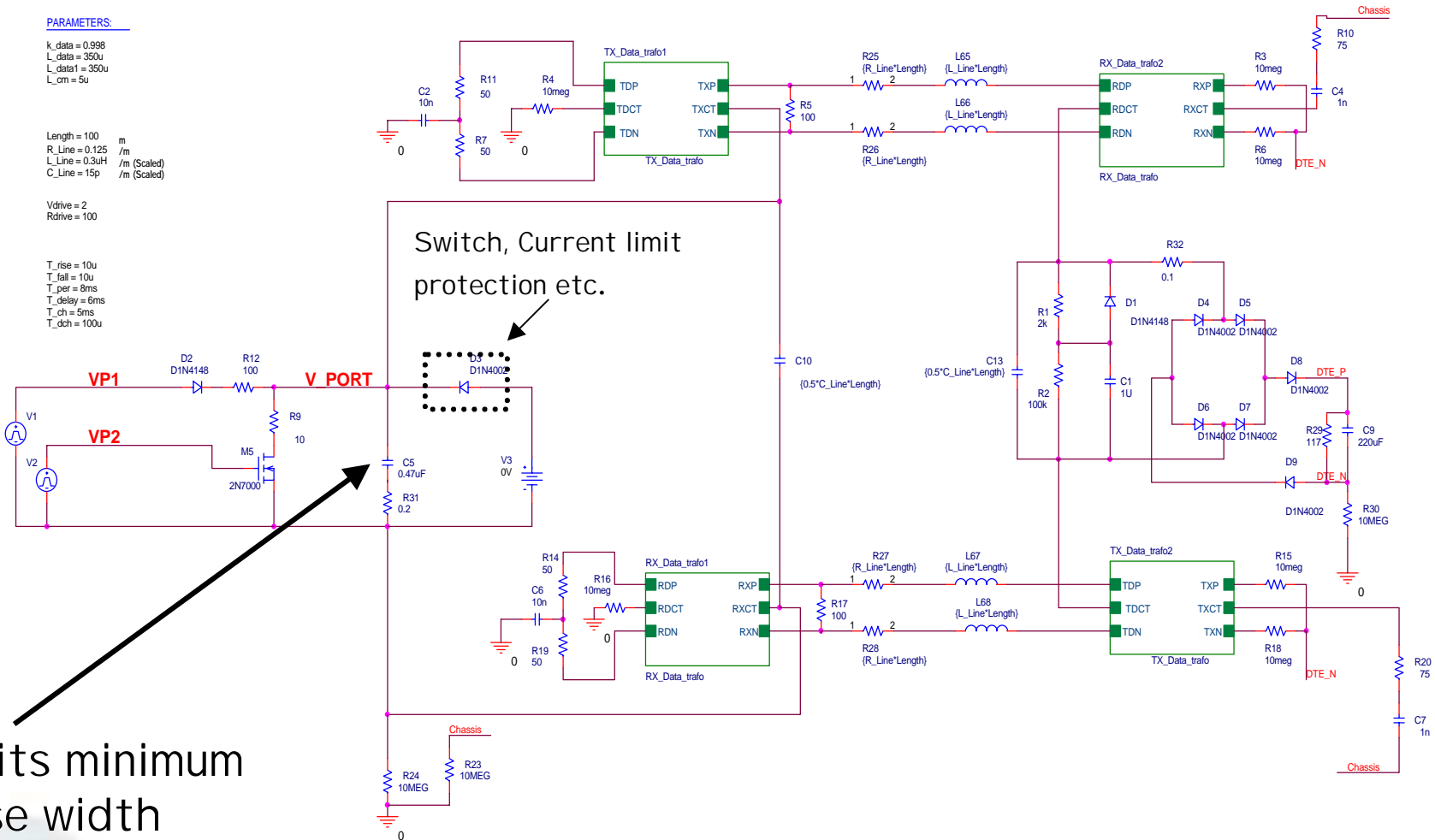
**PARAMETERS:**

$k_{data} = 0.998$   
 $L_{data} = 350\mu$   
 $L_{data1} = 350\mu$   
 $L_{cm} = 5\mu$

Length = 100 m  
 $R_{Line} = 0.125 /m$   
 $L_{Line} = 0.3\mu H /m$  (Scaled)  
 $C_{Line} = 15p /m$  (Scaled)

Vdrive = 2  
Rdrive = 100

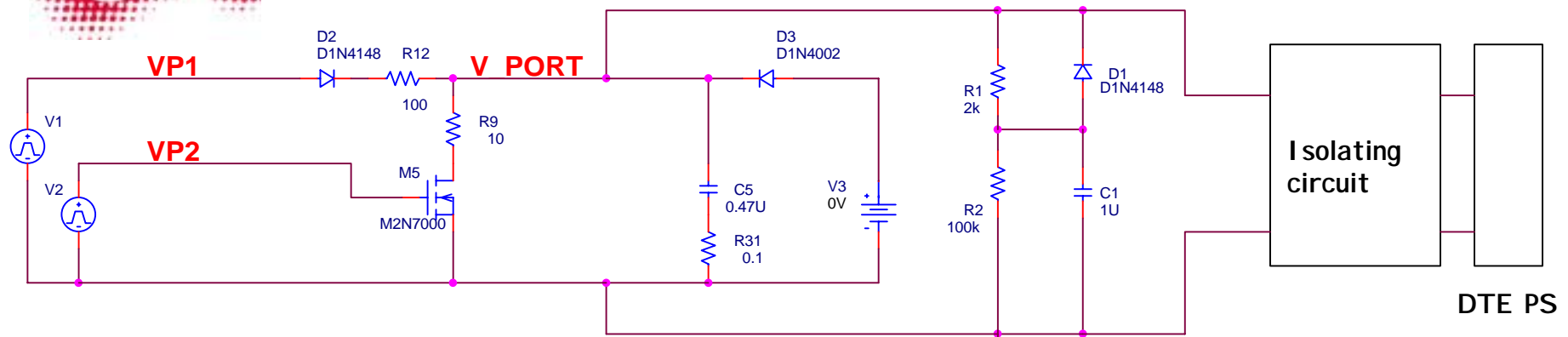
$T_{rise} = 10\mu$   
 $T_{fall} = 10\mu$   
 $T_{par} = 8ms$   
 $T_{delay} = 6ms$   
 $T_{ch} = 5ms$   
 $T_{dch} = 100\mu$



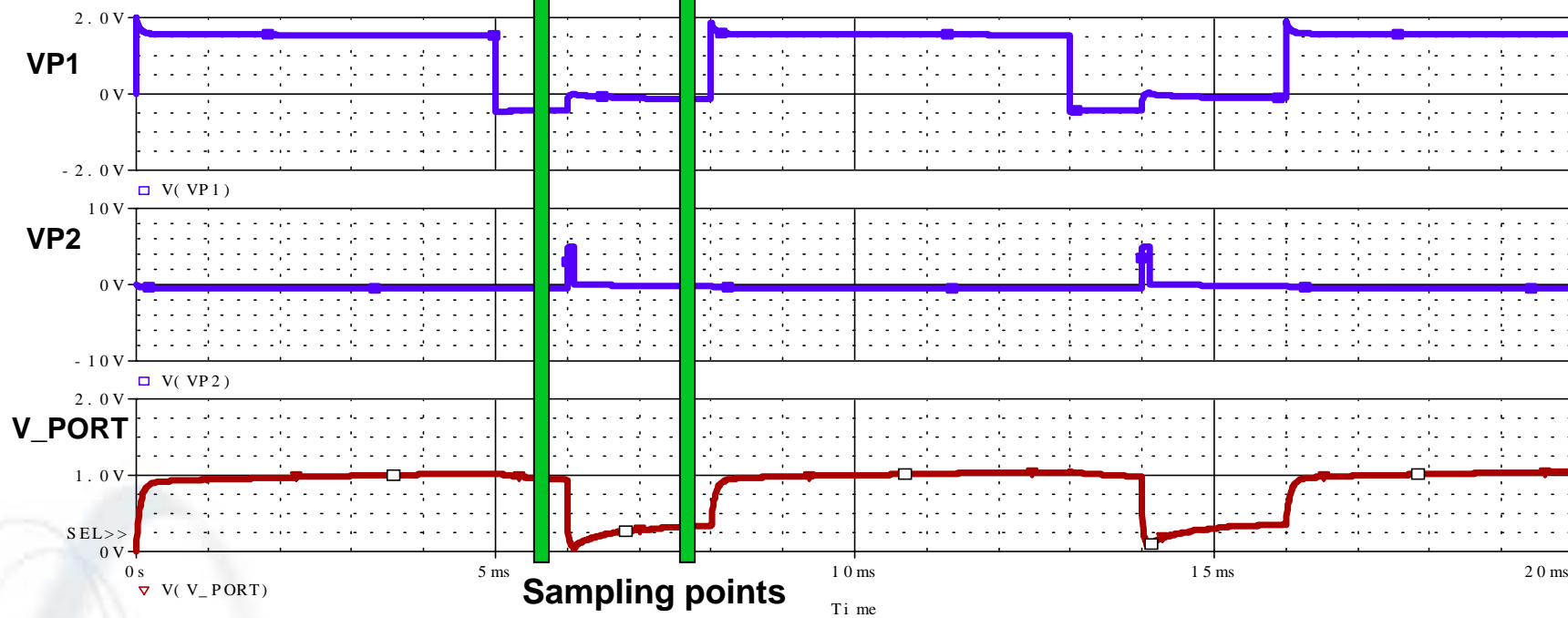
Limits minimum pulse width



# Simplified Transformer-less Implementation Model

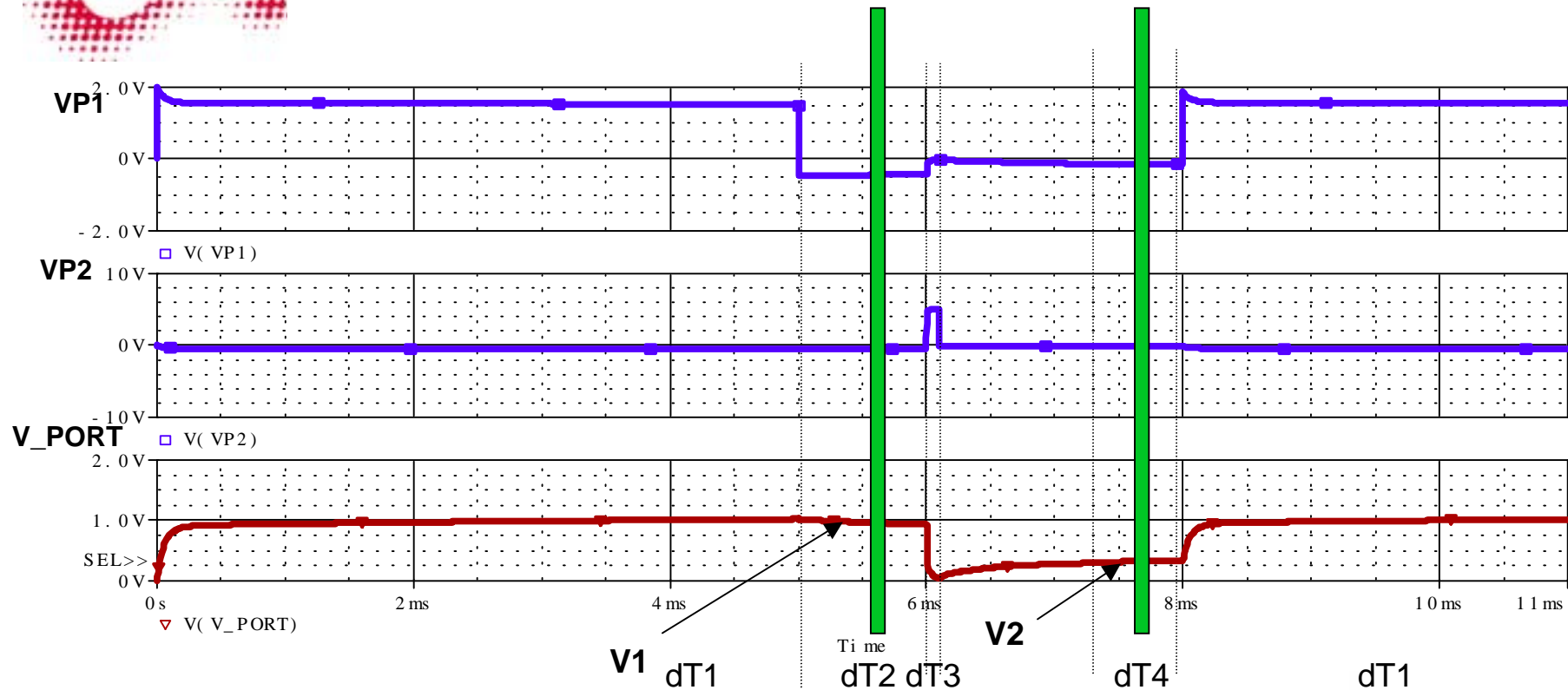


### Parallel Voltage Feed-Voltage Sense





## Transformer-less Implementation - Waveforms



dT1: Diode is at non-conduction direction, Cap is charged to V1.

dT2: Port output pulse voltage peak is sensed for  $V1 \pm TBD\%$  within dT2 gape.

dT3: Diode is in conducting direction, by shorting the port for limited time dT3.

dT4: Port output pulse voltage valley is sensed for  $V2 = 0.7V \pm TBD\%$  within dT4 gape.

- All other digital pulse manipulation and processing apply to this concept as well and are conceptually similar to Series Feed solutions (with the transformers...)



## Transformer-less solution - Concept Principles

- Parallel probing signal feeding method
- AC coupled diode elements are detected by two pulse sources with different characteristics.
- Detected signal is unique function of coupled diode elements values.
- Immunity to ambiguous detection is ensured by pseudo randomly changing pulse width on both pulse sources.
  - In addition to behavioral signature detection, higher level of detection reliability can be achieved by utilizing the forward and reversed AC coupled diode time constant network.



## Comparison between probing signal Implementation methods

Parameters-DTE side	Single Transformer	Double Transformer	With Out Transformer
Coupled diode elements	No Change	No Change	No Change
Coupled diode elements values	No Change	No Change	No Change
Parameters-PSE side			
Pulse amplitude	No Change	No Change	No Change
Pulse width	5uS	5uS	5uS to 5mS
Pulse Frequency	5Khz - 25Khz	5Khz - 25Khz	100Hz - 2KHz
Imunity to false detection	Digital Processing	Digital Processing	Digital Processing
Impact on EMI	No Change	No Change	Better
Pulse manipulation and processing concept	No Change	No Change	No Change
Imunity to ESD(See separate presentation)	No Change	No Change	No Change
Other Interface hardware(Data path)	No Change	No Change	No Change
Parameters-System			
PSE to DTE competability	No Change	No Change	No Change
Integration into Silicon	NA	NA	Possible
Cost Reduction	limited	limited	Possible
Footprint Reduction	limited	limited	Possible
Port to GND isolation achieved by	Coupling transformer	Coupling transformer	48V DC/DC conv.
Port to Port Isolation achieved by	Coupling transformer & 48V DC/DC conv.	Coupling transformer & 48V DC/DC conv.	48V DC/DC conv.

## Implication on Detection Parameters Specifications

- Same coupled diode signature circuit is used in all probing signal feeding methods
- Proposed coupled diode and pulse parameters specifications should not limit implementation methods
- Transformers and silicon implementations will be feasible if a wider range of parameters be specified:
  - Frequency ( 5Khz to 25Khz and 100Hz to 2Khz)
  - Pulse width (5uS, 5uS to 5ms)
  - Pulse Amplitude TBD
  - Pulse average power (TBD mW max.)
  - Successful detection if TBDmin to 256max consecutive positive detection cycles where received.

## What next?

- Additional investigation and testing are needed
  - Optimizing total detection time
  - Setting pulse width and duty cycle range as function of Coupled Diode element values.
  - Lab tests and further theoretical analysis to find if discovery process can be fooled.
  - With acknowledgments to Vladimir Portonov & Alon Ferenz for their help.

## Annex A - Two Transformer solution

### Requirements from coupling transformer

- $I_m$  = Coupling transformer primary magnetizing current
- $I_{sc}$  = Coupling transformer secondary current during diode conduction mode.
- $Z_t$  = Total series impedance off whole link during diode conduction mode.  $Z_t = 40\text{-}80\Omega$
- $V_t$  = Coupling transformer secondary peak voltage
- $pw$  = Probing pulse width
- $F$  = Probing pulse frequency
- $Duty = pw \cdot F$
- $L_s$  = series inductance caused by link inductance + common mode filter inductance located in the data transformer.
- $L_s = 30\text{-}150\mu\text{H}$
- Allowing 10% loss on detected pulse amplitude due to voltage drop on high impedance series elements.
- $L_m / (L_m + L_s) = 0.9 \Rightarrow L_m > 9L_s$
- $I_{drive\_avg} = 0.5I_m \cdot Duty = 0.5 \cdot Duty \cdot V_t \cdot Duty / (F \cdot L_m) = 0.5 \cdot Duty^2 \cdot V_t / (F \cdot L_m)$
- $L_m > 0.5 \cdot Duty^2 \cdot V_t / (I_{drive\_avg} \cdot F)$
- $L_m > \max\{9L_s, 0.5 \cdot Duty^2 \cdot V_t / (I_{drive\_avg} \cdot F)\} = 1.350\text{mH}$

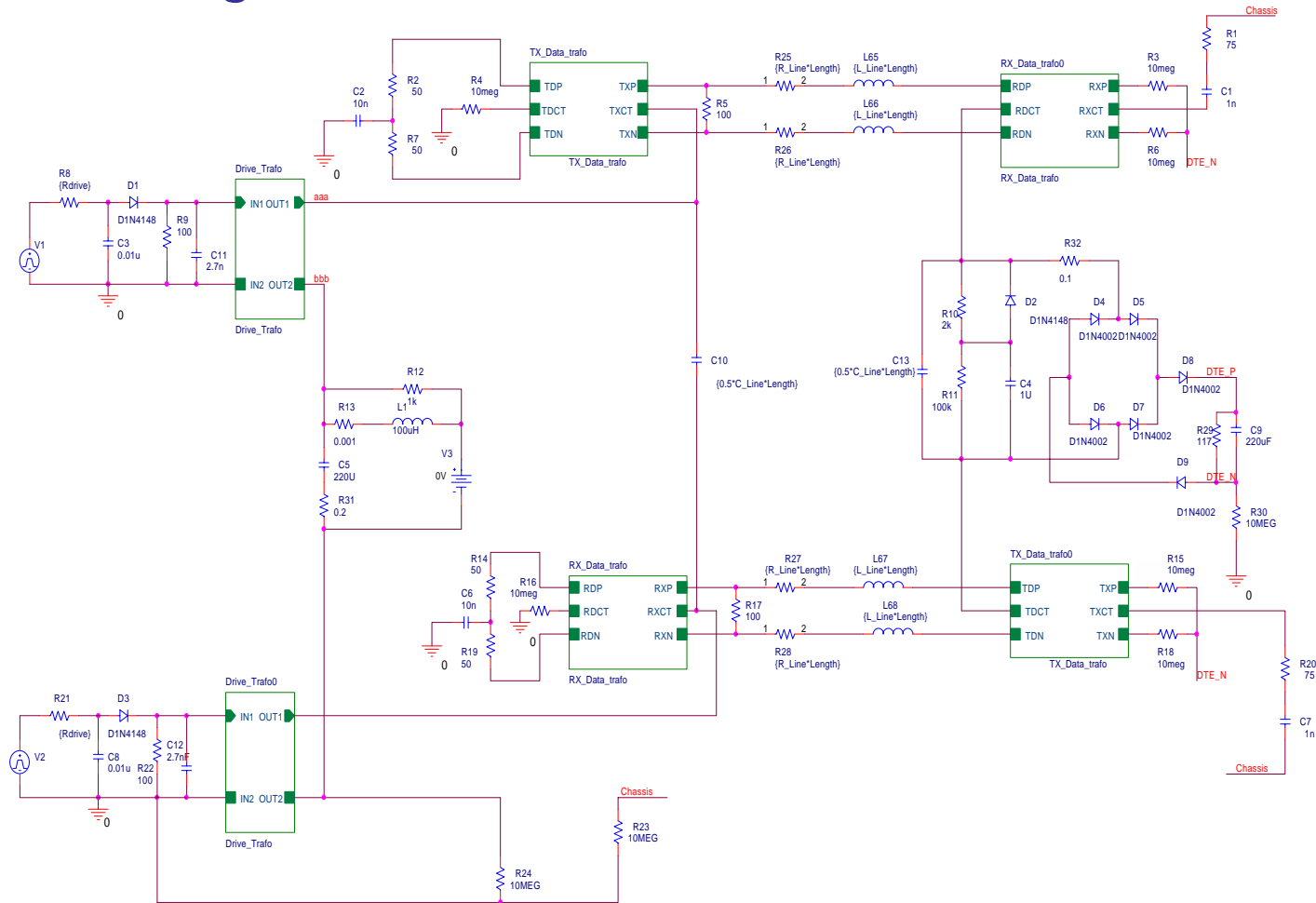
## Annex B - Single Transformer solution Requirements From Coupling transformer

- $I_m$  = Coupling transformer primary magnetizing current
- $I_{sc}$  = Coupling transformer secondary current during diode conduction mode.
- $Z_t$  = Total series impedance off whole link during diode conduction mode.  $Z_t = 40\text{-}80\Omega$
- $V_t$  = Coupling transformer secondary peak voltage
- $pw$  = Probing pulse width
- $F$  = Probing pulse frequency
- $Duty = pw \cdot F$
- $L_s$  = series inductance caused by link inductance + common mode filter inductance located in the data transformer
- For keeping detection resolution within safe margin:  $I_m < I_{sc} / 10$
- $I_{sc} = V_t / Z_t = 25\text{mA} - 50\text{mA}$
- $L_m > V_t / (I_m / pw) = 2 / (0.1 \cdot 25\text{mA} / 5\mu\text{S}) = 4\text{mH}$
- $L_m > 4\text{mH}$

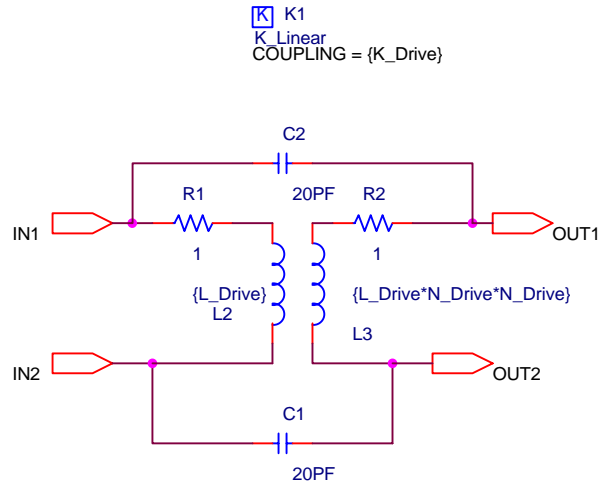
# Annex C - Setup B Electrical Model for Circuit Elements During Detection Mode

**PARAMETERS:**

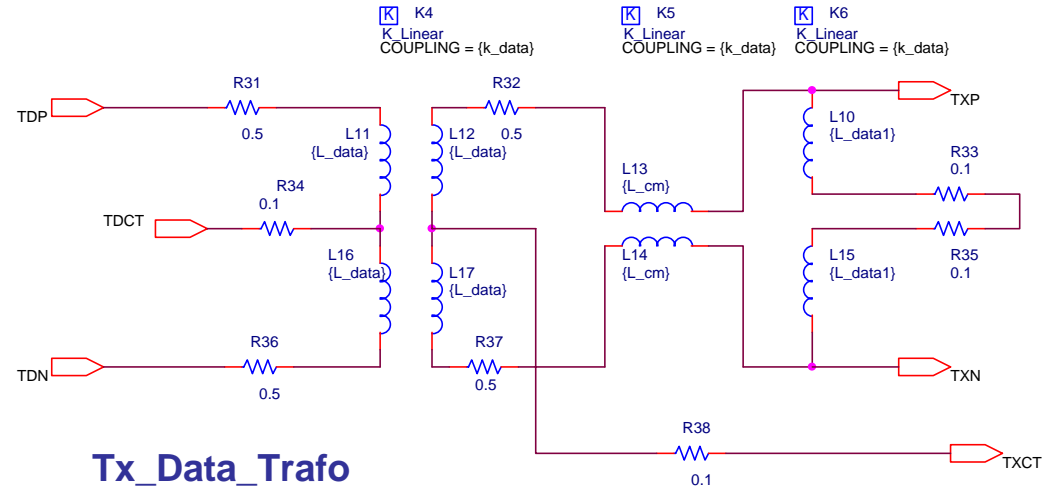
$k\_data = 0.998$   
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 $L\_Drive = 1.2mH$   
 $N\_Drive = 1$   
  
 $Length = 100\ m$   
 $R\_Line = 0.125\ /m\ (Scaled)$   
 $L\_Line = 0.3uH\ /m\ (Scaled)$   
 $C\_Line = 15pF\ /m\ (Scaled)$



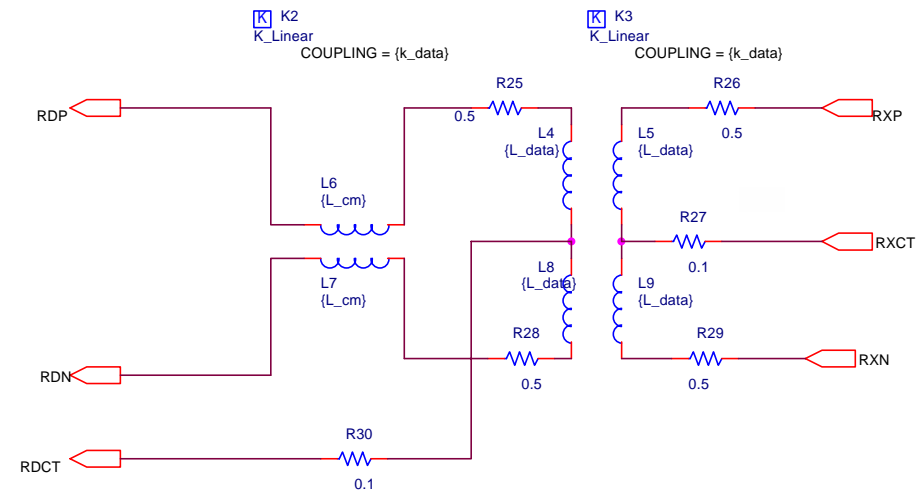
# Annex C - Cont.



**Drive\_Trafo**



**Tx\_Data\_Trafo**



**Rx\_Data\_Trafo**